GENERAL DESCRIPTION

ALD310708A/ALD310708 high precision monolithic quad P-Channel MOSFET arrays are matched at the factory using ALD’s proven EPAD® CMOS technology. This device is available in a quad version and is a member of the EPAD® Matched Pair MOSFET Family. The ALD310708A/ALD310708 is a P-channel version of the popular ALD110808A/ALD110808 Precision Threshold device. Together, these two MOSFET series enable complementary precision N-Channel and P-Channel MOSFET array based circuits.

Intended for low voltage and low power small signal applications, the ALD310708A/ALD310708 features precision -0.80V Gate Threshold Voltage, which enables circuit designs with very low operating voltages such as 2V power supplies where the circuits operate below the threshold voltage of the ALD310708A/ALD310708. This feature also enhances input/output signal operating ranges, especially in very low operating voltage environments. With these low threshold precision devices, a circuit with multiple cascading stages can be constructed to operate at extremely low supply or bias voltage levels. ALD310708A/ALD310708 also features high input impedance (2.5 x 10^{10} \Omega) and high DC current gain (>10^8).

ALD310708A/ALD310708 MOSFETs are designed for exceptional matching of device electrical characteristics. The Gate Threshold Voltage $V_{GS(th)}$ is set precisely at -0.80V +/-0.02V, featuring a typical offset voltage of only +/-0.001V (1mV). As these devices are on the same monolithic chip, they also exhibit excellent temperature tracking characteristics. They are versatile design components for a broad range of precision analog applications such as basic building blocks for current mirrors, matching circuits, current sources, differential amplifier input stages, transmission gates, and multiplexers. These devices also excel in limited operating voltage applications such as very low level precision voltage-clamps. In addition to matched pair electrical characteristics, each individual MOSFET exhibits individual well controlled manufacturing characteristics, enabling the user to depend on tight design limits from different production batches.

(Continued on next page)

APPLICATIONS

- 0.5% precision current mirrors and current sources
- Low Tempco (<= 50ppm/°C) current mirrors/sources
- Energy harvesting circuits
- Very low voltage analog and digital circuits
- Backup battery circuits & power failure detectors
- Precision low level voltage-clamps
- Low level zero-crossing detector
- Source followers and buffers
- Precision capacitive probes and sensor interfaces
- Precision charge detectors and charge integrators
- Discrete differential amplifier input stage
- Peak-detectors and level-shifters
- High-side switches and Sample-and-Hold switches
- Precision current multipliers
- Discrete analog switches / multiplexers
- Discrete voltage comparators

FEATURES & BENEFITS

- Precision matched Gate Threshold Voltages
- Precision offset voltages ($V_{OS}$):
  - ALD310708A: 1mV typical
  - ALD310708: 2mV typical
- Sub-threshold voltage operation
- Low min. operating voltage of less than 0.8V
- Ultra low min. operating current of less than 1nA
- Nano-power operation
- Wide dynamic operating current ranges
- Exponential operating current ranges
- Matched transconductance and output conductance
- Matched and tracked temperature characteristics
- Tight lot-to-lot parametric control
- Positive, zero, and negative $V_{GS(th)}$ tempco bias currents
- Low input capacitance
- Low input/output leakage currents

ORDERING INFORMATION

("L" suffix denotes lead-free (RoHS))

<table>
<thead>
<tr>
<th>Operating Temperature Range *</th>
<th>0°C to +70°C</th>
</tr>
</thead>
<tbody>
<tr>
<td>16-Pin SOIC Package</td>
<td>16-Pin Plastic Dip Package</td>
</tr>
<tr>
<td>ALD310708ASCL</td>
<td>ALD310708APCL</td>
</tr>
<tr>
<td>ALD310708SCL</td>
<td>ALD310708PCL</td>
</tr>
</tbody>
</table>

*Contact factory for industrial temp. range or user-specified threshold voltage values.

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GENERAL DESCRIPTION (cont.)
These devices are built to offer minimum offset voltage and differential thermal response, and they can also be used for switching and amplifying applications in -0.80V to -8.0V (+/-0.40V to +/-4.0V) powered systems where low input bias current, low input capacitance, and fast switching speed are desired. These devices, exhibiting well controlled turn-off and sub-threshold characteristics, operate the same as standard enhancement mode P-Channel MOSFETs. However, the precision of the Gate Threshold Voltage enable two key additional characteristics, or operating features. First, the operating current level varies exponentially with gate bias voltage at or below the Gate Threshold Voltage (subthreshold region). Second, the circuit can be biased and operated in the subthreshold region with nA of bias current and nW of power dissipation.

For most general applications, connect the V+ pin to the most positive voltage and the V- and IC (internally-connected) pins to the most negative voltage in the system. All other pins must have voltages within these voltage limits at all times. Standard ESD protection facilities and procedures for static sensitive devices are required when handling these devices.

ABSOLUTE MAXIMUM RATINGS

- Drain-Source voltage, V_DS: -8.0V
- Gate-Source voltage, V_GS: -8.0V
- Operating Current: 80mA
- Power dissipation: 500mW
- Operating temperature range: 0°C to +70°C
- Storage temperature range: -65°C to +150°C
- Lead temperature, 10 seconds: +260°C

CAUTION: ESD Sensitive Device. Use static control procedures in ESD controlled environment.

OPERATING ELECTRICAL CHARACTERISTICS

V+ = +5V   V- = GND   TA = 25°C unless otherwise specified

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>ALD310708A</th>
<th>ALD310708</th>
<th>Unit</th>
<th>Test Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Gate Threshold Voltage</td>
<td>V_GS(th)</td>
<td>-0.82</td>
<td>-0.80</td>
<td>-0.78</td>
<td>V</td>
</tr>
<tr>
<td>Offset Voltage</td>
<td>V_OS</td>
<td>1</td>
<td>5</td>
<td>2</td>
<td>20 mV</td>
</tr>
<tr>
<td>Gate Threshold Temperature</td>
<td>TCV_GS(th)</td>
<td>-2</td>
<td>-2</td>
<td>mV/°C</td>
<td></td>
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<tr>
<td>Drain Source On Current</td>
<td>I_DS(ON)</td>
<td>-1.65</td>
<td>-1.65</td>
<td>mA</td>
<td>V_GS = V_DS = -5.0V</td>
</tr>
<tr>
<td>Transconductance Current²</td>
<td>G_F</td>
<td>570</td>
<td>570</td>
<td>µA/V</td>
<td>V_GS = V_DS = -5.0V</td>
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<tr>
<td>Transconductance Mismatch</td>
<td>∆G_F</td>
<td>1</td>
<td>1</td>
<td>%</td>
<td>V_GS = V_DS = -5.0V</td>
</tr>
<tr>
<td>Output Conductance²</td>
<td>G_OS</td>
<td>48</td>
<td>48</td>
<td>µA/V</td>
<td>V_GS(th) = -4.0V, V_DS = -5.0V</td>
</tr>
<tr>
<td>Drain Source On Resistance</td>
<td>R_DS(ON)</td>
<td>1.25</td>
<td>1.25</td>
<td>KΩ</td>
<td>V_GS = -5.0V, V_DS = -0.1V</td>
</tr>
<tr>
<td>Drain Source On Resistance Mismatch</td>
<td>∆R_DS(ON)</td>
<td>1</td>
<td>1</td>
<td>%</td>
<td></td>
</tr>
<tr>
<td>Drain Source Breakdown</td>
<td>BVD_X</td>
<td>-8.0</td>
<td>-8.0</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Drain Source Leakage Current¹</td>
<td>I_D(OF)</td>
<td>400</td>
<td>400</td>
<td>pA</td>
<td></td>
</tr>
<tr>
<td>Gate Leakage Current</td>
<td>I_GS</td>
<td>200</td>
<td>200</td>
<td>pA</td>
<td></td>
</tr>
<tr>
<td>Input Capacitance²</td>
<td>C_II</td>
<td>2.5</td>
<td>2.5</td>
<td>pF</td>
<td></td>
</tr>
</tbody>
</table>

Notes: ¹ Consists of junction leakage currents
² Sample tested parameters
TYPICAL PERFORMANCE CHARACTERISTICS

**OUTPUT CHARACTERISTICS**

- **DRAIN SOURCE ON VOLTAGE - VDS(ON) (V)**
- **DRAIN SOURCE ON CURRENT**
  - **IDS(ON) (µA)**
  - -0.4  -0.3  -0.2  -0.1  0.0  0.1  0.2  0.3  0.4  0.5
  - 500
  - 400
  - 300
  - 200
  - 100
  - 0

**FORWARD TRANSFER CHARACTERISTICS**

- **GATE SOURCE VOLTAGE - VGS (V)**
- **DRAIN SOURCE ON CURRENT**
  - **IDS(ON) (µA)**
  - 1.0  0.5  -0.5  -1.0  -2.0  -3.0  -4.0  -5.0
  - 100000
  - 10000
  - 1000
  - 100
  - 10
  - 1
  - 0.1
  - 0.01

**LOW VOLTAGE OUTPUT CHARACTERISTICS**

- **GATE SOURCE VOLTAGE - VGS (V)**
- **DRAIN SOURCE ON CURRENT**
  - **IDS(ON) (µA)**
  - -0.5  -0.4  -0.3  -0.2  -0.1  0.0  0.1  0.2  0.3  0.4  0.5
  - 500
  - 400
  - 300
  - 200
  - 100
  - 0

**DRAIN SOURCE ON CURRENT vs. GATE AND DRAIN SOURCE VOLTAGE**

- **VGS = VDS**
- **V+ = 0V**
- **V- = -5V**
- **TA = +25°C**

ALD310700/ALD310702
ALD310704
ALD310708
TYPICAL PERFORMANCE CHARACTERISTICS (cont.)

**FORWARD TRANSFER CHARACTERISTICS EXPANDED (SUBTHRESHOLD)**

- **DRAIN SOURCE ON CURRENT (µA)**
- **GATE SOURCE OVERDRIVE VOLTAGE (V)**
- **AMBIENT TEMPERATURE (°C)**

**GATE THRESHOLD VOLTAGE vs. V- VOLTAGE**

- **GATE THRESHOLD VOLTAGE (VGS(th)) = -0.800 V**
- **GATE THRESHOLD VOLTAGE (VGS(th)) = -0.400 V**
- **GATE THRESHOLD VOLTAGE (VGS(th)) = 0.000 V**
- **GATE THRESHOLD VOLTAGE (VGS(th)) = -0.200 V**

**FORWARD TRANSFER CHARACTERISTICS FURTHER EXPANDED (SUBTHRESHOLD)**

**GATE THRESHOLD VOLTAGE vs. SUBSTRATE BIAS**

- **GATE THRESHOLD VOLTAGE (VGS(th)) = -0.700 V**
- **VGS(th) = -0.400 V**
- **VGS(th) = 0.000 V**
- **VGS(th) = -0.100 V**
**TYPICAL PERFORMANCE CHARACTERISTICS (cont.)**

**TRANSConDUCTANCE vs. AMBIENT TEMPERATURE**

- **TRANSCONDUCTANCE** vs. **GATE SOURCE OVERVOLTAGE**
  - **TRANSCONDUCTANCE** vs. **GATE THRESHOLD VOLTAGE**
  - **OUTPUT CONDUCTANCE** vs. **DRAIN SOURCE ON VOLTAGE**
  - **ZERO TEMPERATURE COEFFICIENT (ZTC)**

**FET**

- **VGS = VGS(th) - 4.0V**
- **VGS = VGS(th) - 0.5V**
- **VGS = VGS(th) - 1.0V**
- **VDS = -5.0V**
- **V+ = 0V**
- **V- = -5V**
**TYPICAL APPLICATIONS**

**LOW VOLTAGE CURRENT SOURCE MIRROR**

\[ V^+ = +2.0 \text{V to } +5.0 \text{V} \]

\[ \text{ISOURCE} = \frac{V^+ - V_t}{R_{SET}} \]

\[ M_1, M_2: \text{N-Channel MOSFET} \]
\[ M_3, M_4: \text{P-Channel MOSFET} \]

**LOW VOLTAGE CURRENT SOURCE W/ GATE CONTROL**

\[ V^+ = +2.0 \text{V to } +5.0 \text{V} \]

\[ \text{Digital Logic Control of Current Source} \]

**LOW VOLTAGE DIFFERENTIAL AMPLIFIER**

\[ V^+ = +5.0 \text{V} \]

\[ \text{Current Source} \]

\[ M_1, M_2: \text{N-Channel MOSFET} \]
\[ M_3, M_4: \text{P-Channel MOSFET} \]

**0.5% PRECISION LOW VOLTAGE CURRENT SOURCE MULTIPLICATION**

\[ V^+ = +2.0 \text{V to } +5.0 \text{V} \]

\[ \text{ISOURCE} = \text{ISET} \cdot X \cdot Y \]

\[ M_{NSET}, M_{N1}, M_{N2}, M_{NX}: \text{N-Channel MOSFET} \]
\[ M_{PSET}, M_{P1}, M_{P2}, M_{PY}: \text{P-Channel MOSFET} \]
0.5% LOW VOLTAGE PRECISION CURRENT MIRRORS

$$I_{SOURCE} = I_{SET} = \frac{V^+ - V_t}{R_{SET}}$$

M1, M2: N-Channel MOSFET

0.5% PRECISION LOW VOLTAGE CASCODE CURRENT SOURCES

$$I_{SOURCE} = 3 \cdot I_{SET} = 3 \left( \frac{V^+ - 2V_t}{R_{SET}} \right)$$

MPA1...MPA4: ALD310708 P-Channel MOSFET (1st individual pkg)
MPB1...MPB4: ALD310708 P-Channel MOSFET (2nd individual pkg)

0.5% PRECISION LOW TEMPCO CASCODE CURRENT SOURCES

Temperature stable <= 50ppm/°C when ISET = 57µA.
SOIC-16 PACKAGE DRAWING

16 Pin Plastic SOIC Package

<table>
<thead>
<tr>
<th>Dim</th>
<th>Millimeters</th>
<th>Inches</th>
</tr>
</thead>
<tbody>
<tr>
<td>A</td>
<td>1.35 1.75</td>
<td>0.053 0.069</td>
</tr>
<tr>
<td>A₁</td>
<td>0.10 0.25</td>
<td>0.004 0.010</td>
</tr>
<tr>
<td>b</td>
<td>0.35 0.45</td>
<td>0.014 0.018</td>
</tr>
<tr>
<td>C</td>
<td>0.18 0.25</td>
<td>0.007 0.010</td>
</tr>
<tr>
<td>D-16</td>
<td>9.80 10.00</td>
<td>0.385 0.394</td>
</tr>
<tr>
<td>E</td>
<td>3.50 4.05</td>
<td>0.140 0.160</td>
</tr>
<tr>
<td>e</td>
<td>1.27 BSC</td>
<td>0.050 BSC</td>
</tr>
<tr>
<td>H</td>
<td>5.70 6.30</td>
<td>0.224 0.248</td>
</tr>
<tr>
<td>L</td>
<td>0.60 0.937</td>
<td>0.024 0.037</td>
</tr>
<tr>
<td>Õ</td>
<td>0° 8°</td>
<td>0° 8°</td>
</tr>
<tr>
<td>S</td>
<td>0.25 0.50</td>
<td>0.010 0.020</td>
</tr>
</tbody>
</table>
16 Pin Plastic DIP Package

<table>
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<th>Inches</th>
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<tbody>
<tr>
<td>A</td>
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<td>A1</td>
<td>0.38</td>
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<tr>
<td>A2</td>
<td>1.27</td>
<td>0.05</td>
</tr>
<tr>
<td>b</td>
<td>0.89</td>
<td>0.03</td>
</tr>
<tr>
<td>b1</td>
<td>0.38</td>
<td>0.01</td>
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<tr>
<td>c</td>
<td>0.20</td>
<td>0.00</td>
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<tr>
<td>D-16</td>
<td>18.93</td>
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<td>E</td>
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<td>E1</td>
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<td>e</td>
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<tr>
<td>e1</td>
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<td>L</td>
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<td>S-16</td>
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<td>0.01</td>
</tr>
<tr>
<td>ø</td>
<td>0°</td>
<td>0°</td>
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